



SHEET 1 OF 1

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
245818US2SERIAL NO.  
10/720,133

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Takashi FUJIWARAFILING DATE  
November 25, 2003GROUP  
~~2486~~ 2143

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/A.S./	AA	5,701,413	12/23/1997	Ferruccio ZULIAN, et al. (corresponding to JP 7-311751; previously filed on April 13, 2006)			
	AB						
	AC						
	AD						
	AE						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/A.S./	AO	EP 0 608 663 B1	08/03/1994	Europe (corresponding to JP 7-311751; previously filed on April 13, 2006)		
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

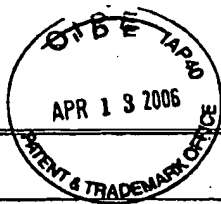
	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

/Anish Sikri/ (07/28/2007) 2/8/08 AS

Date Considered 2/8/08 07/28/2007

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

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APPLICANT

Takashi FUJIWARA

FILING DATE

November 25, 2003

GROUP

2188 2143

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/A.S./	AA						
	AB						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	7-311751	11/28/1995	JAPAN (with English Abstract)		X
	AP	1-154273	06/16/1989	JAPAN (with English Abstract)		X
	AQ	8-263459	10/11/1996	JAPAN (with English Abstract)		X
	AR	2001-142777	05/25/2001	JAPAN (with English Abstract)		X
/A.S./	AS	6-4401	01/14/1994	JAPAN (with English Abstract)		X
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
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	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

/Anish Sikri/ (07/28/2007) *AS* 2/8/08

Date Considered

07/28/2007 2/8/08

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NEW APPLICATION

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takashi FUJIWARA

FILING DATE

HEREWITH

11/25/03

GROUP

2143

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/A.S./	AA	4,669,056	05/26/87	Donald E. WALDECKER, et al.			
/A.S./	AB	6,026,464	02/15/00	Gary Leon COHEN			
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## FOREIGN PATENT DOCUMENTS

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					YES	NO
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	AP					
	AQ					
	AR					
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## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
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	AY		
	AZ		

☐ Additional References sheet(s) attached

Examiner

/Anish Sikri/ (07/28/2007)

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